

Search Notes

Application/Control No.

10/689,256

Examiner

Tan V. Mai

Applicant(s)/Patent under
Reexamination

BEAUMONT, MARK

Art Unit

2193

SEARCHED

Class	Subclass	Date	Examiner
updated	search	5/15/2007	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search (see search history printout(s))	5/15/2007	MAI